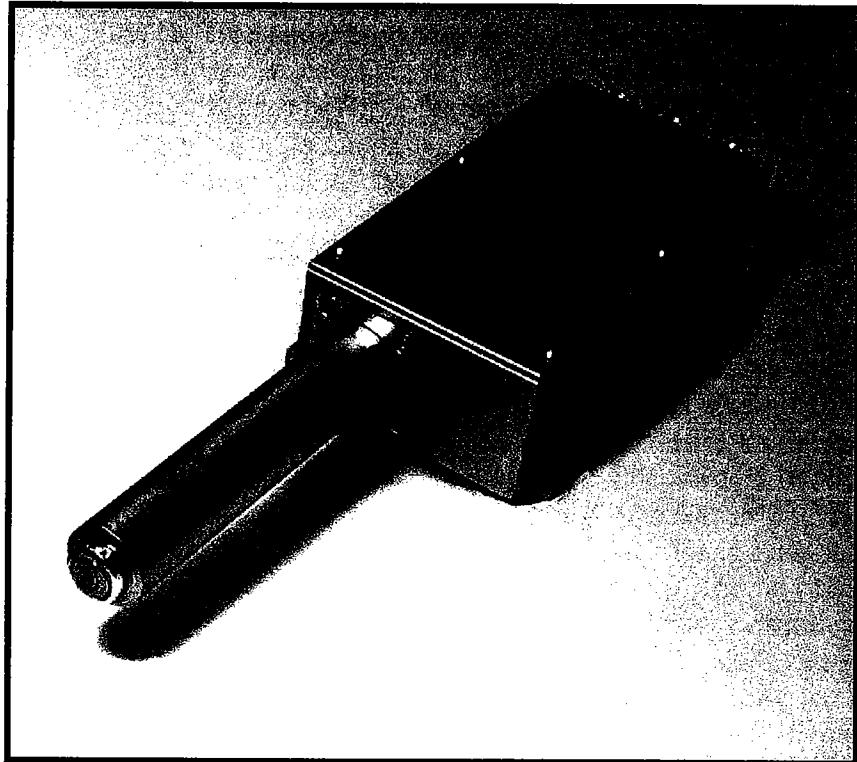


DP00152

AXAS

(Analog X-ray Acquisition System)



Operating Manual



KETEK

Creative Detector Solutions

Caution

- This document contains data valid only for the AXAS system you purchased it with. Please do not use it as a reference to operate any other devices you purchased earlier or later on from our company.
- Do not drop or cause mechanical shock to the AXAS, especially if you purchased a system equipped with an AP3.3 radiation entrance window.
- Avoid any kind of high forces and/or torques during mounting of the AXAS, especially if you purchased a system equipped with an AP3.3 radiation entrance window.
- Do not operate the AXAS at a temperature (measured at the steel electronics case) above 35 °C. Apply additional cooling to the steel case if necessary (contact to heat sink, gills, PC air cooler etc.). The performance of the system will noticeably worsen above this temperature.
- Never change the setting of any potentiometer inside the electronics case. Every system is adjusted carefully before delivery. We will not take any warranty for systems damaged by manipulation of these potentiometers or adjust the system a second time for free, if you did not contact us first.
- If you purchased a system and an ADC/MCA it is possible to adjust some detector parameters (voltages) via software. Do not change these settings without advice of KETEK. You may damage the system seriously by changing these settings. No warranty will be taken by KETEK in this case.
- Do not touch or apply any mechanical force or shock to the radiation entrance window (Beryllium or Ap3.3) integrated at the front end of the AXAS. The integrity of each window is checked carefully before delivery and no warranty will be taken if it is damaged by the customer. Moreover breaking the window during operation of the system will most probably destroy the whole detector.
- Take care to connect the output contacts and the test input properly as it is described in this manual later on.
- Take care to follow the instructions regarding the power input to the system given in this manual. Otherwise the system may be destroyed. We strongly recommend our own power supply.
- Do not expose the detector to a high particle flux (such as ions or electrons). Damages done by incident particles will not be covered under warranty.
- Concerning radiation damage done by photons a maximal dose is guaranteed for each detector. In case of malfunction it is due to the customer to bring evidence that this dose has not been applied.



* The picture on the title page shows the AXAS detector system

AXAS Datasheet

Every detector system produced by KETEK GmbH is tested electrically and spectroscopically. Testing parameters and results achieved in the final qualification are reported below.
A leakage test (MIL-STD-883, Method 1014.10) was performed and passed.

AXAS-Serial-NO: 00151
 AXAS-Batch-NO: 24-05
 TO8-Serial-NO: N0221
 Class: SDD7-1403000

DP 00152

Spectroscopic results

	FWHM:	158 eV	@ 0.25 μ s	@ -20 °C
			(chip temperature)	
P/B ratio:	3358			
Count rate [cps]:	1 198			

TO8 housing

Cap Type:	LE	Entrance window:	MOXTEK AP3.3; 100 +/-10 mbar
Collimator:	Zr On-chip	Window diameter:	3.0 mm (7mm ²)
Collimator support:		Auxiliary Coll. dia.:	

WARNING:

1. Sealing

The TO8-housing is closed hermetically. A leakage test MIL-STD-883 was performed. However every mechanical stress on the detector module can damage the module entrance window or the PIN-s introducing a leakage in the housing.

2 Radiation hardness

Radiation hardness of the silicon drift detector has been investigated using synchrotron radiation.

With a total dose of 1012 absorbed photons on the SDD active area, typical variation of the energy resolution in terms of FWHM are less than 2% and peak/background ratio variation are less than 10%.
 Radiation hardness is energy dependent. The analyses made represents the worst case, assuming incoming x-rays in an energy range between 10 and 15 keV, where the damage on the integrated electronics is maximized. Outside this energy range is the detector radiation harder.

The spectroscopic results can be achieved, when the temperature of the AXAS housing is +20°C.

Our technical staff is at your disposal for any kind of questions
 mail to: support@keteck.net
<http://www.keteck.net>

LE Silicon Drift Detector Datasheet

Every detector module produced by KETEK GmbH is tested electrically and spectroscopically. Testing parameters and results achieved in the final qualification are reported below. A leakage test (MIL-STD-883, Method 1014.10) was performed and passed.

For proper operation of the silicon drift detector please follow the operation parameters listed in the data sheet.

Serial Number:

N0221

Chip Type:

SDD-10-140 -PNS
SDD10 (7 mm² coll)

Active area:

7 mm²

Spectroscopic results

(measurements performed with ⁵⁵Fe x-ray source at 5.895 keV)

FWHM @ -20°C:	139 eV	@ 1.00 μs
FWHM @ -10°C:	149 eV	@ 0.50 μs
FWHM @ 0°C:	165.6 eV	@ 0.25 μs
FWHM @ 20°C:	ev	@ 0.25 μs
Peak to background ratio with standard collimator:	3358	

Testing conditions

Count rate [cps]:	1500
Heat sink temperature [°C]:	20

Cooling performance

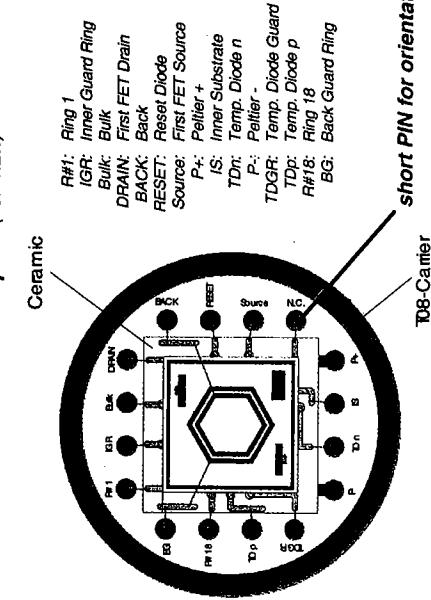
Peltier current [A]:	0.394	-0.703
Temperature difference [K]:	30.4	40.4
Abs. chip temperature [°C]:	-10.0	-20.0
Temp. diode Voltage for 1 μA [V]:	0.54	
Temperature diode sensitivity:	appr. 3 mV/K	

TO8 housing

Collimator:	Zr On-chip
Collimator diameter:	3.0 mm (7mm ²)
Entrance window:	MOXTEK AP3.3; 100 +/-10 mbar

The max. current allowed for the operation of the Peltier thermocooler strongly depends on the thermal characteristics of the system detector-heat sink.
The values specified are suitable for optimal coupling to an external heat sink with low thermal resistance.

TO8 PIN Description (TOP VIEW)



short PIN for orientation

WARNING:

1. **Sealing**
The TO8-housing is closed hermetically. A leakage test MIL-STD-883 was performed. However every mechanical stress on the detector module can damage the module entrance window or the PIN's introducing a leakage in the housing.

2. **Thermal coupling**
Ensure a good thermal coupling between TO8 M4 adapter on bottom of the housing and heat sink. A poor thermal coupling may cause overheating of the detector system already at low peltier currents, damaging the detector irreparably.

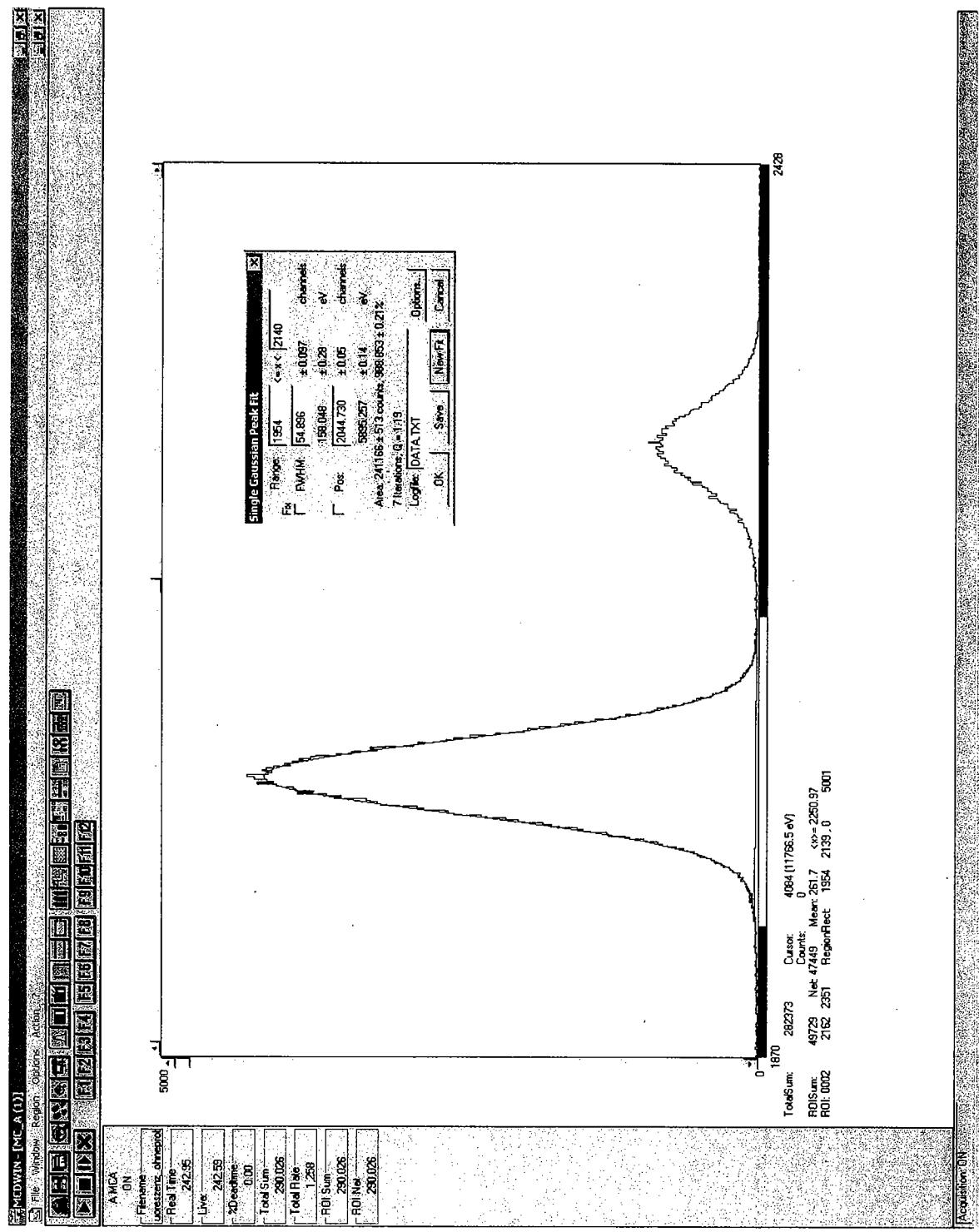
3. **Radiation hardness**

Radiation hardness of the silicon drift detector has been investigated using synchrotron radiation.
With a total dose of 10⁴ absorbed photons on the SDD active area, typical variation of the energy resolution in terms of FWHM are less than 2% and peak/background ratio variation are less than 10%.
Radiation hardness is energy dependent. The analyses made represents the worst case, assuming incoming x-rays in an energy range between 10 and 15 keV, where the damage on the integrated electronics is maximized. Outside this energy range the detector radiation harder.

Our technical staff is at your disposal for any kind of questions

mail to: support@keteck.net
<http://www.keteck.net>

AXAS # 00151
SDD # N0221 @ 0.25 μ s



Operating instructions

The AXAS-detector system should be kind of plug and play. That means you should not have to change anything on the system itself. If this though is necessary contact us first in any case! After you unpacked the different components please connect them to each other and the components you supply by yourself regarding to the connection diagram inside this manual.

Packing list:

You should have received the following components:

- AXAS detector system, including detector, preamplifier, shaping amplifier (removed on customers demand), temperature control and internal power supply
- External ± 12 V power supply if purchased.
- Additional shaping time boards if purchased.
- This manual.
- ADC/MCA incl. set of connection cables and manual if purchased

Dimensions and HD-15 connector:

A technical drawing inside this manual gives the dimensions of the AXAS system, the pin definition of the integrated male HD-15 connector, and the definitions of the other input and output connectors in detail. Please never connect any pin, input or output in a different way or you may destroy the detector. Please note that the drawing corresponds to an AXAS system with a 100 mm snout. So this dimension may vary if you purchased a system with a different snout length.

Shaped output / radiation entrance window:

The BNC / Shaper OUT output provides an amplified, shaped signal (see example inside this manual / typical rise and fall time curves are attached too) within a voltage range from 0 to about 6 V (input impedance 1 mega ohm). It can be used as input signal to any standard ADC, although we recommend our own ADC/MCA (AXAS^{MCA}). The detector is calibrated in a way that the mentioned voltage spread covers a spread of x-ray energies from 0 to the upper energy limit you specified. The theoretical lower limit of the detector is about 200 eV but due to the entrance window you purchased the practical lower limit may be higher (e.g. for Beryllium about 1 keV). For more detailed information on the transmission of your entrance window please have a look at the attached transmission curves.

Pre-amplified output / test pulse input:

If you did not purchase our shaper the BNC / Shaper OUT does not provide any signal. In any case a pre-amplified signal is provided by BNC / Preamp. OUT. BNC / Test Input allows the user to connect a pulse generator to the system and test the output by applying different test pulses.

Pile-up rejection:

The pins 1 and 2 of the HD-15 connector each provide a TTL signal as input for an ADC with integrated pile-up rejection (not_PUR is inverted with respect to PUR / see attached oscilloscope screen shot). If you purchased a power supply these signals can be taken also at the side of the connection plug (PUR = yellow, not_PUR = green)

Ambient temperature:

Please note that the detector performance depends on the ambient temperature you provide. The metal housing of the AXAS system acts as a heat sink for the cooling mechanism of the detector. The housing should not have a temperature above 35 °C during operation. Anyway it is optimal if the housing stays at room temperature or somewhat below. So if possible attach an additional heat sink or apply active cooling to the housing.

Detector temperature:

The current temperature of the SDD detector integrated into your AXAS system can be monitored by reading the voltage given at the two temperature monitor output connectors (see technical drawing). This option is for service purposes mainly. More details are available on request.

Resolution (at high count rates) / shaping time:

Each detector has been tested carefully at the KETEK laboratory at Munich/Germany to redeem the guaranteed specifications. The guaranteed energy resolution was checked with reference to a measurement using the Mn K_α line of a Fe55 x-ray source and a shaping time of 1 µs. Please note that the best resolution you will observe depends on the shaping time and the count rate you use. For more detail have a look at the attached diagram giving the resolution of an example AXAS system in dependence of count rate and shaping time.

Peak shift at high count rates:

For high count rates a peak shift in the recorded spectra may occur depending on the applied count rate. The attached "AXAS – Peak Shift" diagram gives an example of this peak shift. Please note that the example we attached represents a kind of worst case scenario. The actual peak shift is different for every detector and should not exceed the given example by much.

Check the connection diagram:

If your system does not operate properly, please check all the connections referring to the connection diagram. Please also check by the two LEDs if the system is operational. If everything is connected the right way, please contact us before you open the AXAS and change any internal settings. YOU MAY DESTROY THE DETECTOR!!!

KETEK ADC/MCA

If you purchased an AXAS^{MCA} also several AXAS settings can be manipulated via the ADC software. This feature facilitates the service by far and may make a (re-)calibration of the detector system at your site possible. However, please do not change the settings without advice of KETEK or you may damage the detector.

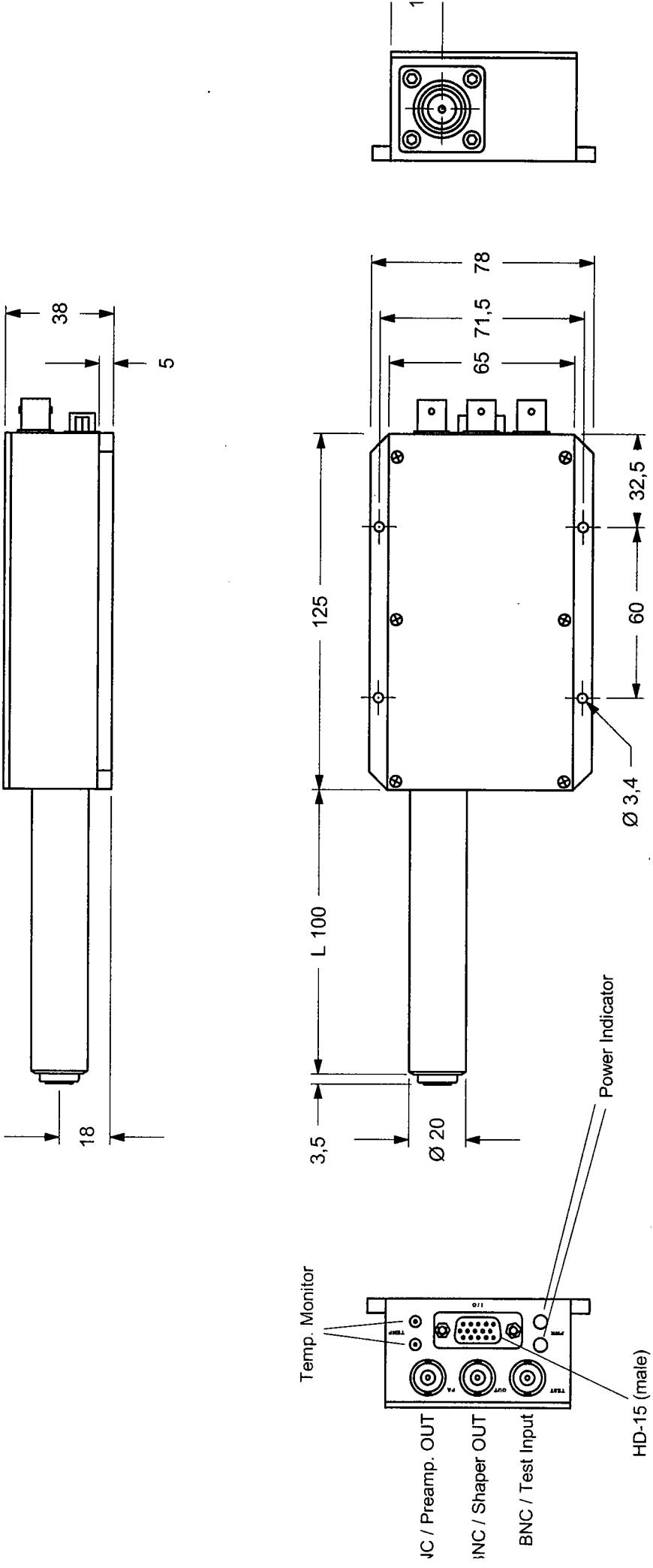
In case of questions or warranty please contact:

Ketek GmbH
Gustav-Heinemann-Ring 125
D-81739 Munich

Mail: support@ketek.net
Tel.: ++498967346770
Fax.: ++498967346777



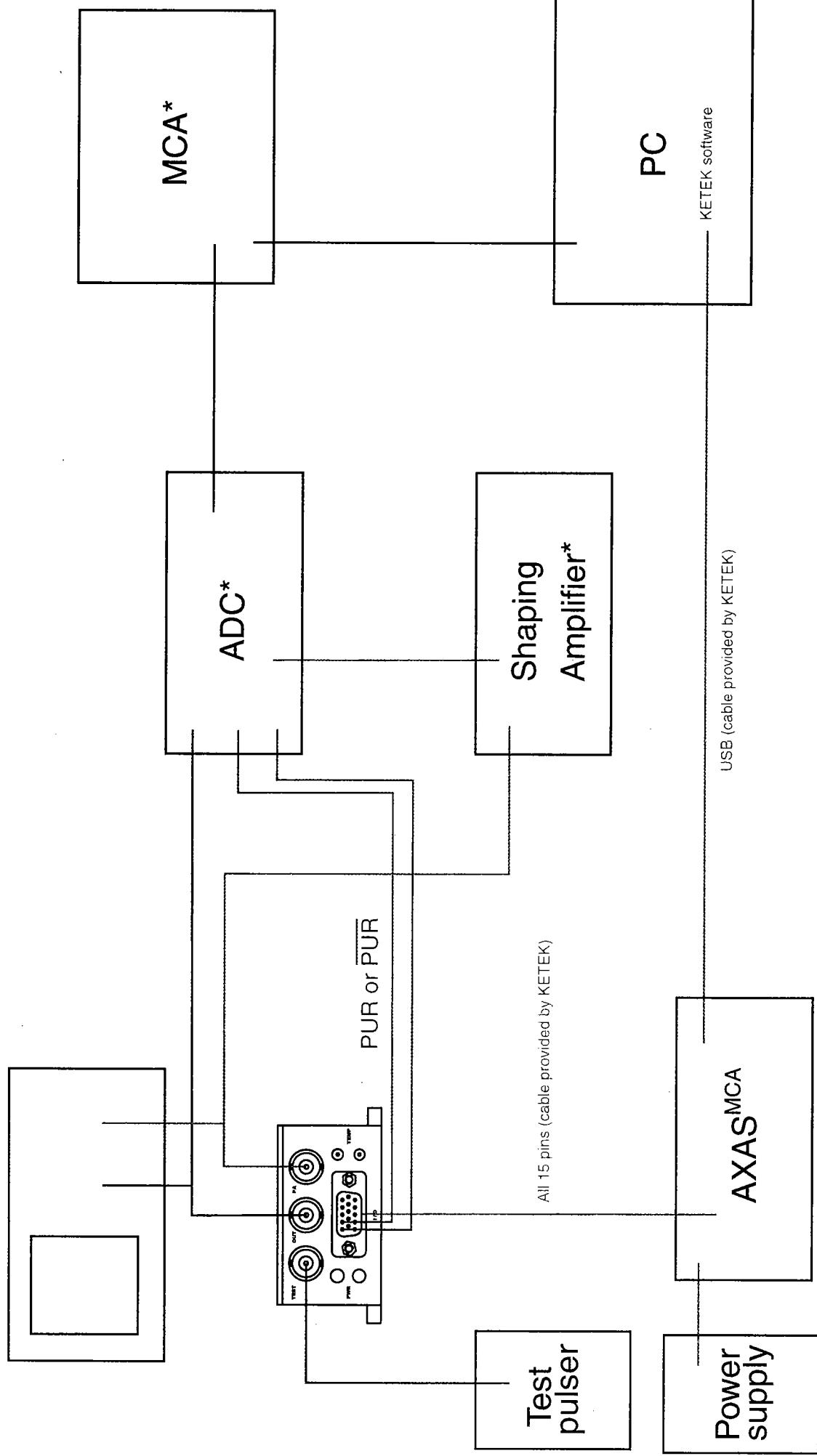
Technical drawing of an AXAS system with a 100 mm snout



2	3	4	5	6	7	8	9	10	11	12	13	14	15
r	PUR	GND	GND	AMON*	+12V	GND	GND	-12V	SCK*	SDO*	SOT*	ALD*	L5318*

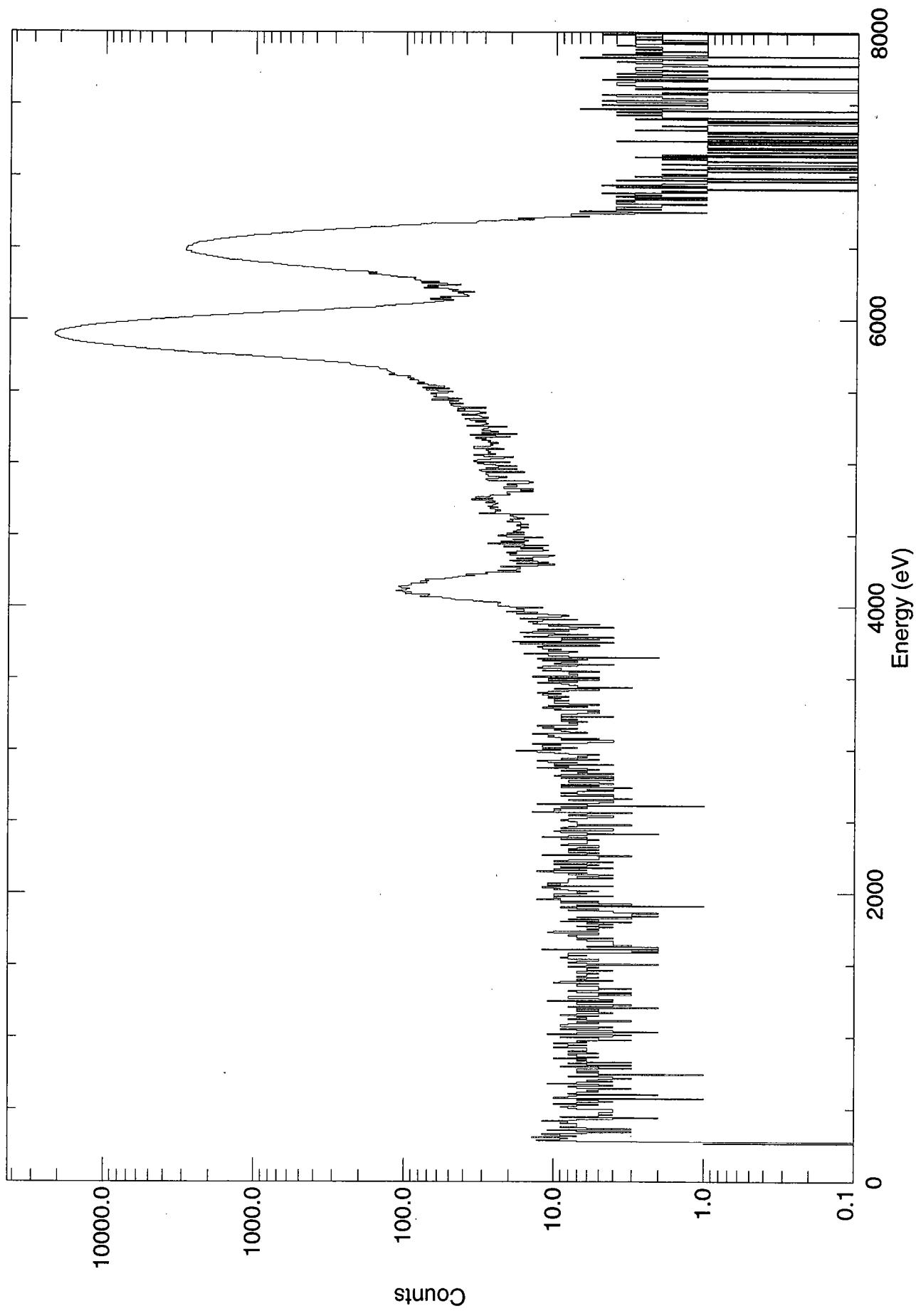
Connection diagram

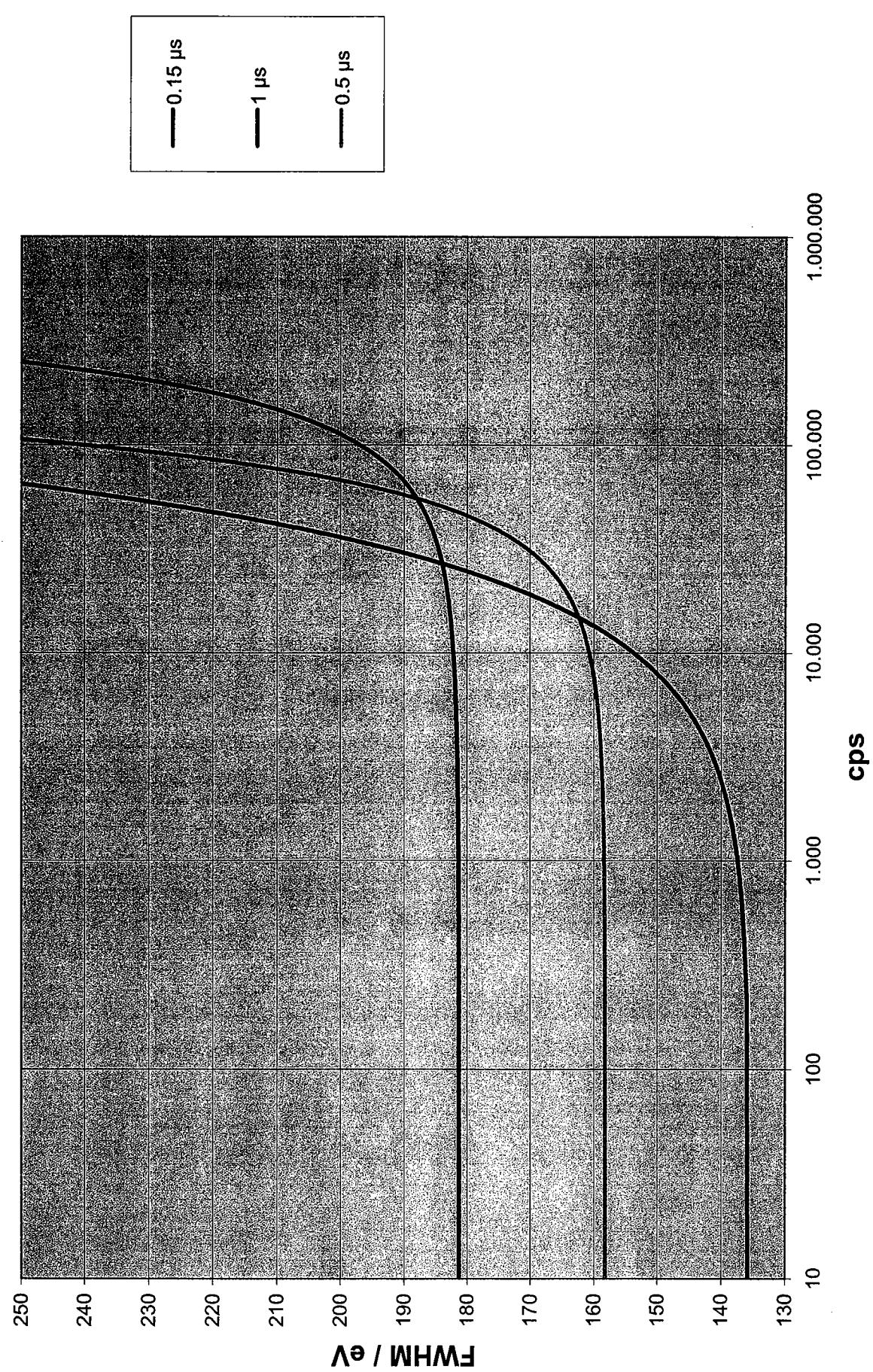
Oscilloscope



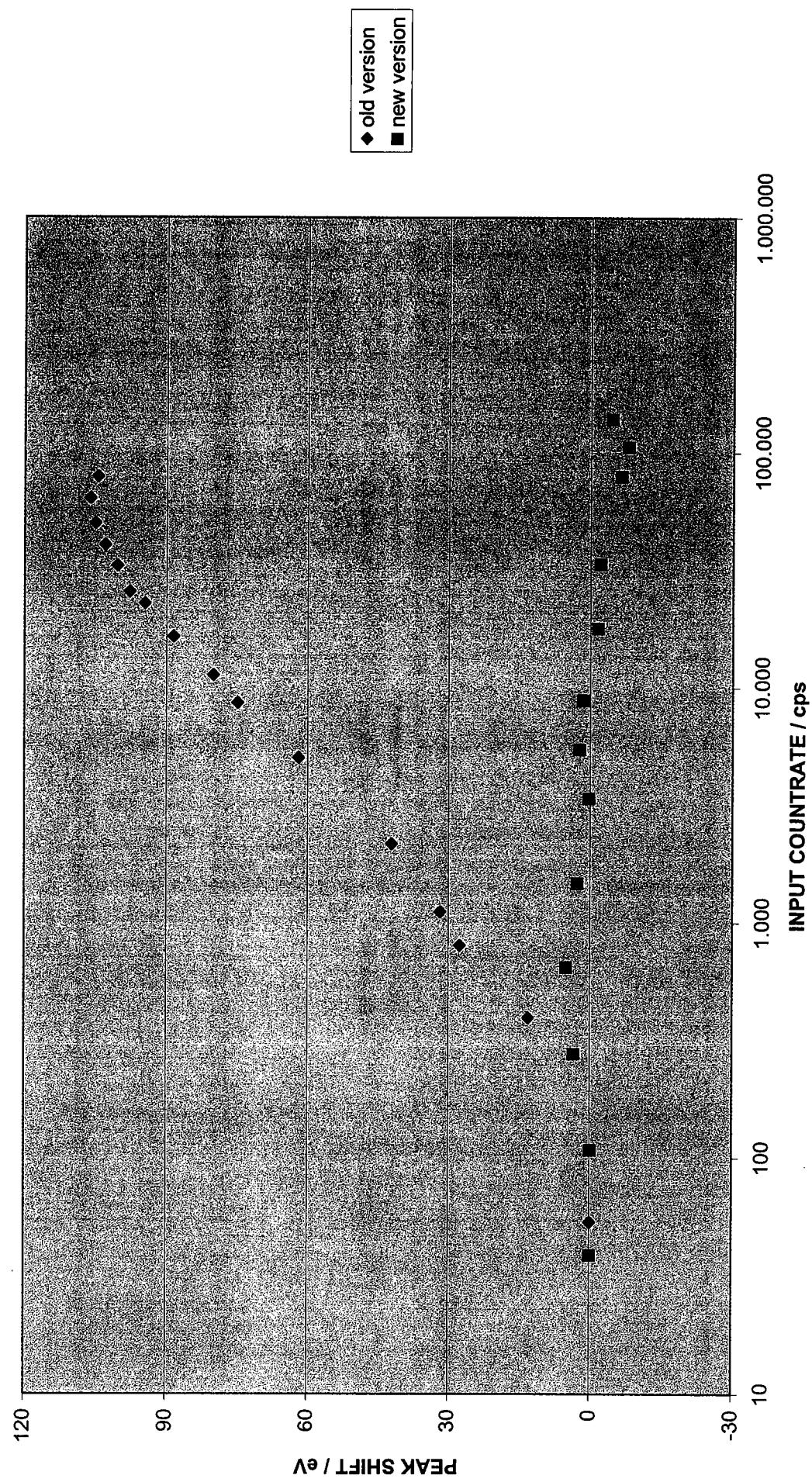
* It is recommended to use Keteks shaping amplifier, which integrated in the AXAS system and KETEKs ADC/MCA AXAS^{MCA}

Example spectrum of a Fe55 radiation source $\sigma(\text{Mn K}_\alpha) = 141 \text{ eV FWHM}$

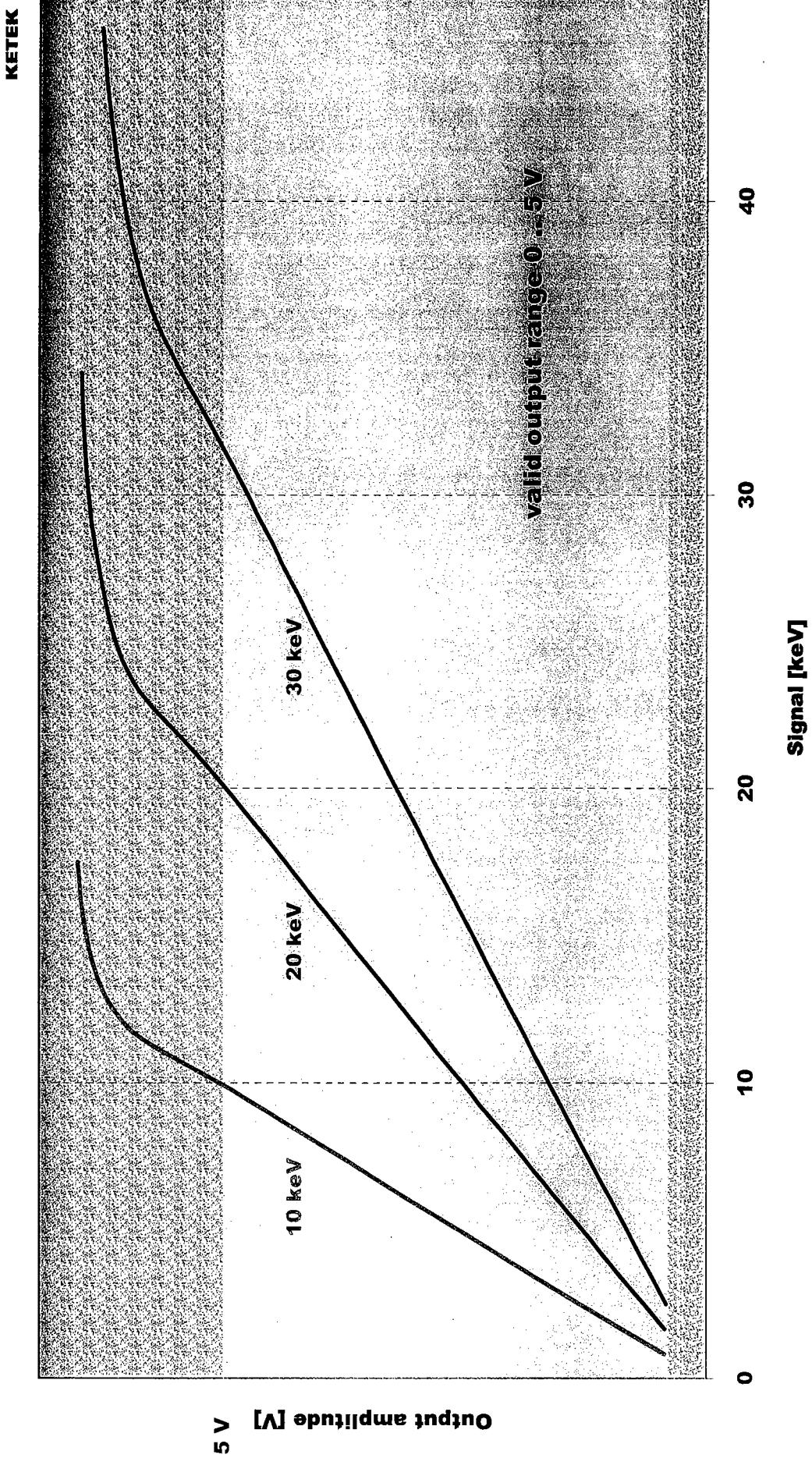




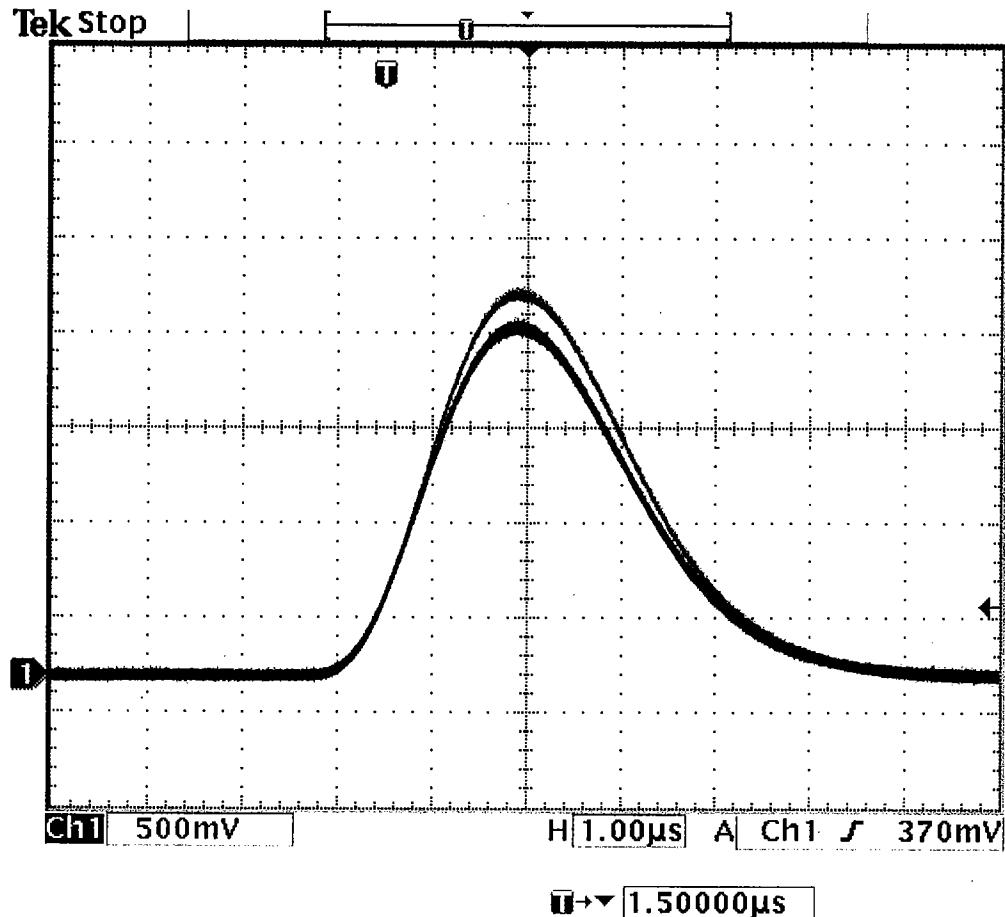
Peak Shift with AXAS 1 μ s



typical AXAS output characteristics

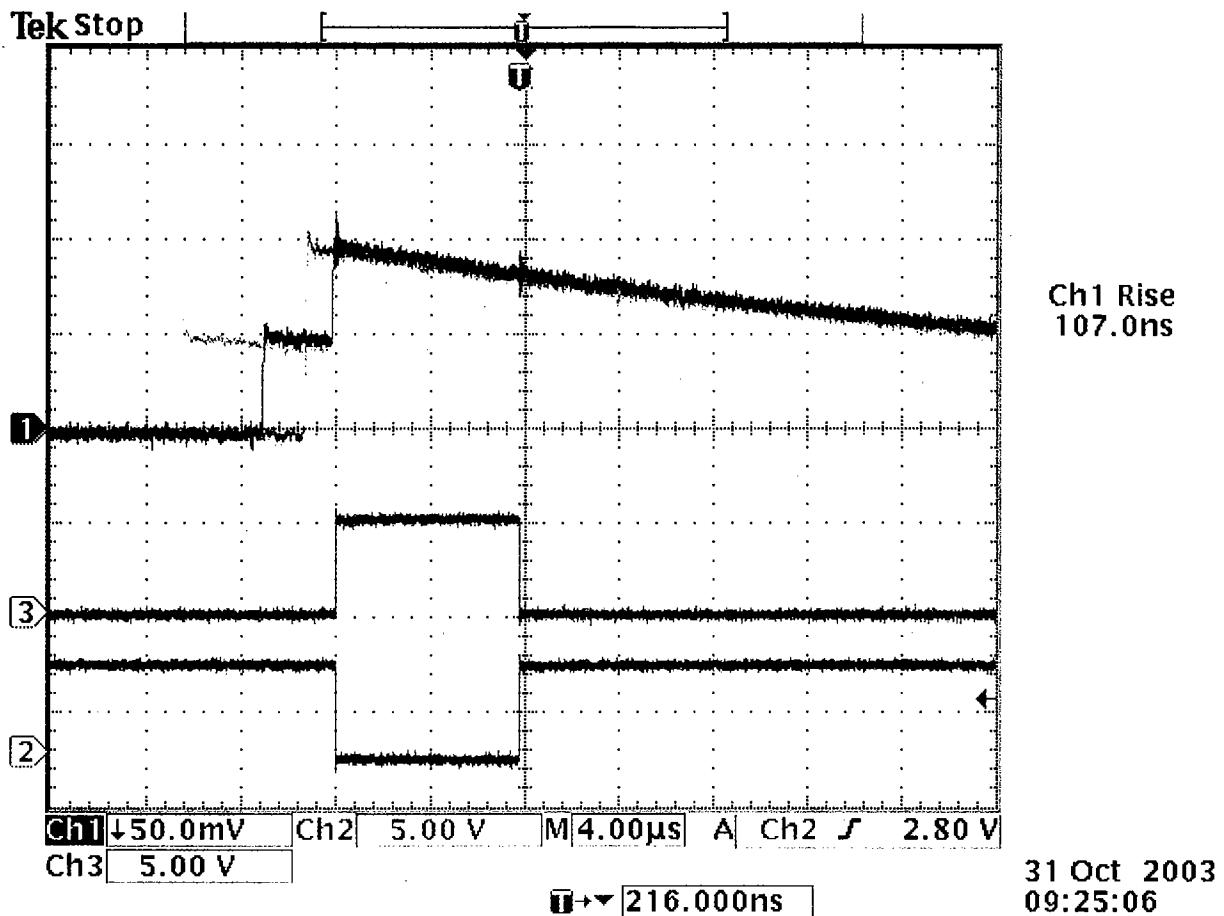


Amplified, shaped output of the AXAS system



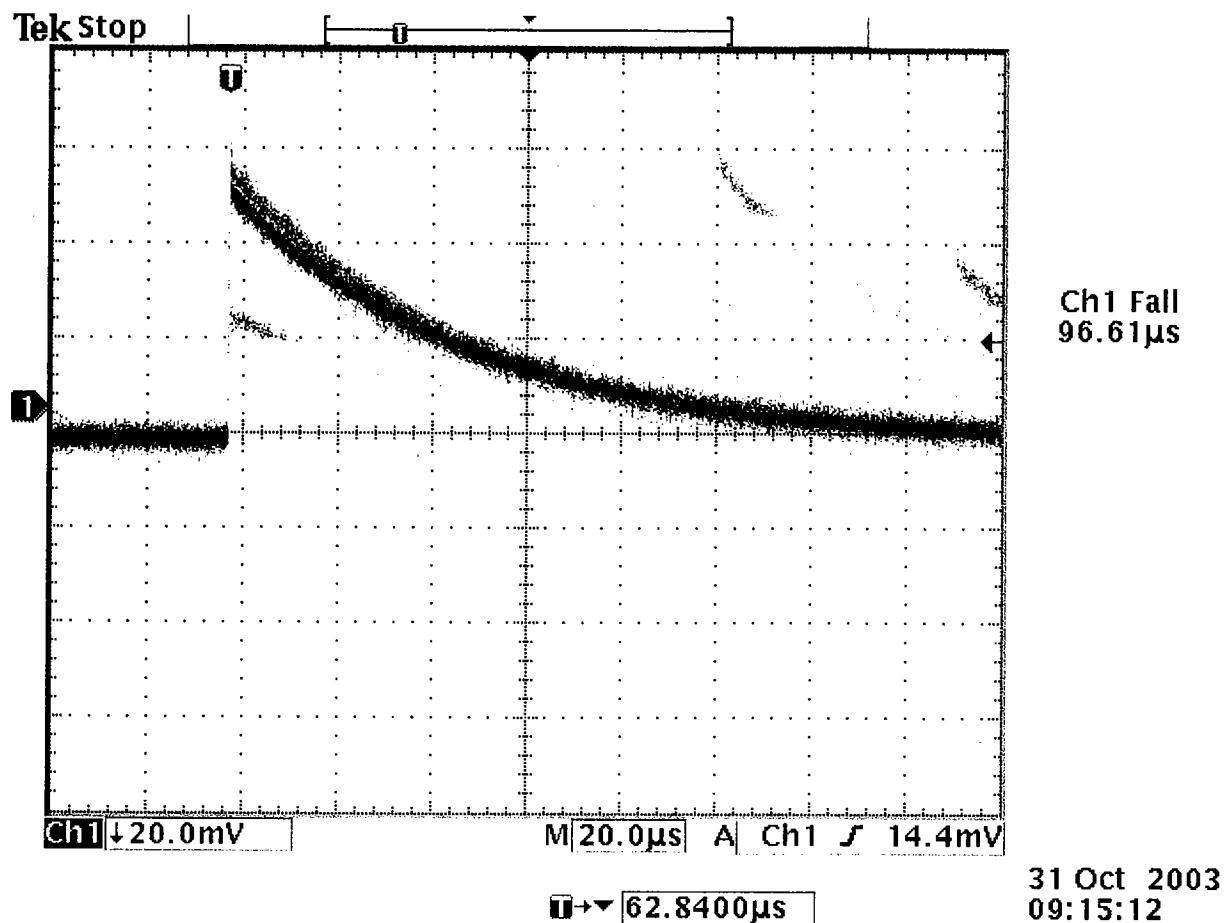
This oscilloscope screen shot shows a typical shaped and amplified output signal of the AXAS system (BNC / Shaper OUT). A Fe⁵⁵ x-ray source was used for irradiation of the detector. The Mn K_α and K_β lines are clearly separated. Please note that the amplitude of the signal depends on the adjusted gain voltage range and the x-ray energy.

Double pulse and PUR TTL pulse



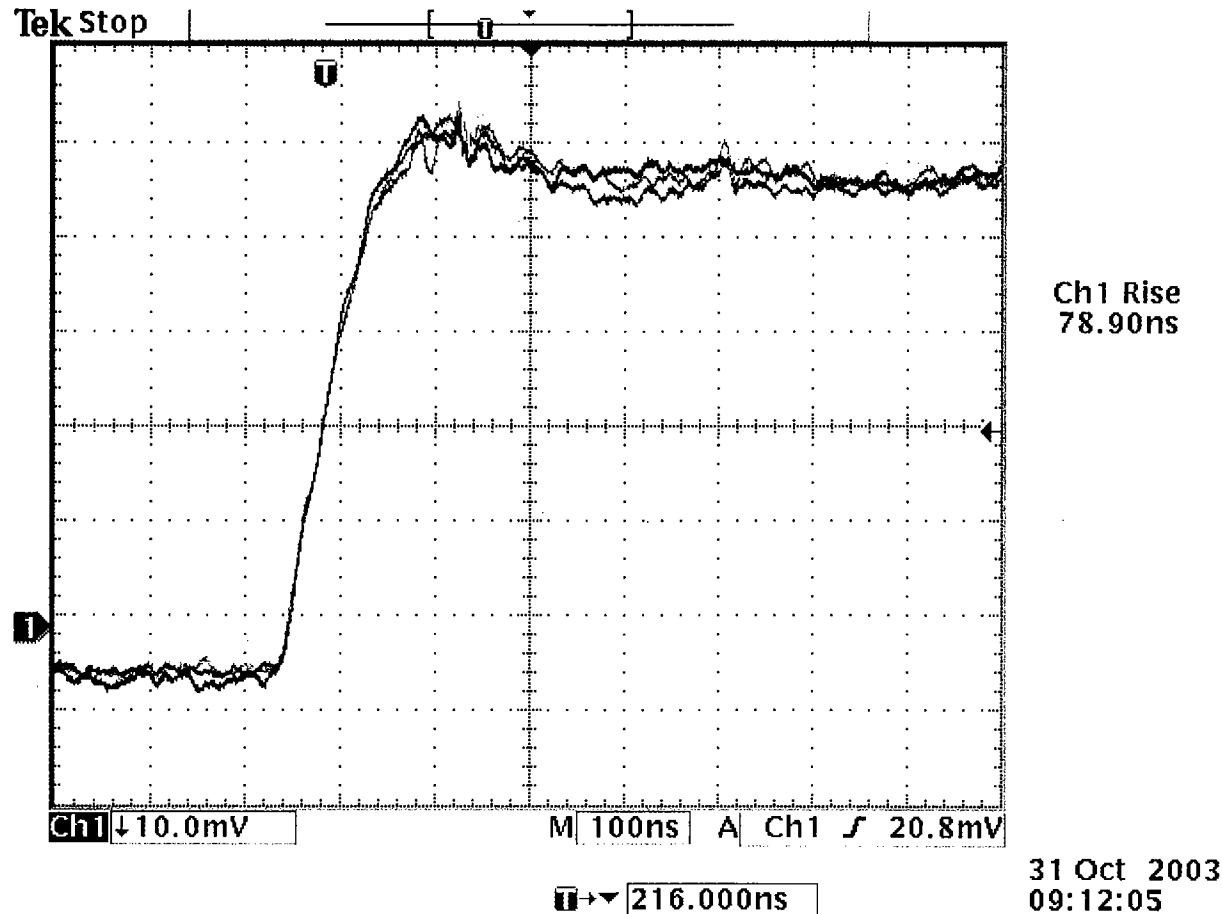
This screen shot shows a typical double (pile up) pulse (upper curve) and the subsequent TTL pulses produced by the AXAS system (lower curves) as input to an optional pile up rejection feature of your ADC. The pink curve shows the PUR, the blue curve the respective inverse PUR (the contact is denoted as PUR with a line above the letters) signal. Please note, that the original output is inverted with respect to this picture.

Fall time of the pre-amplified signal



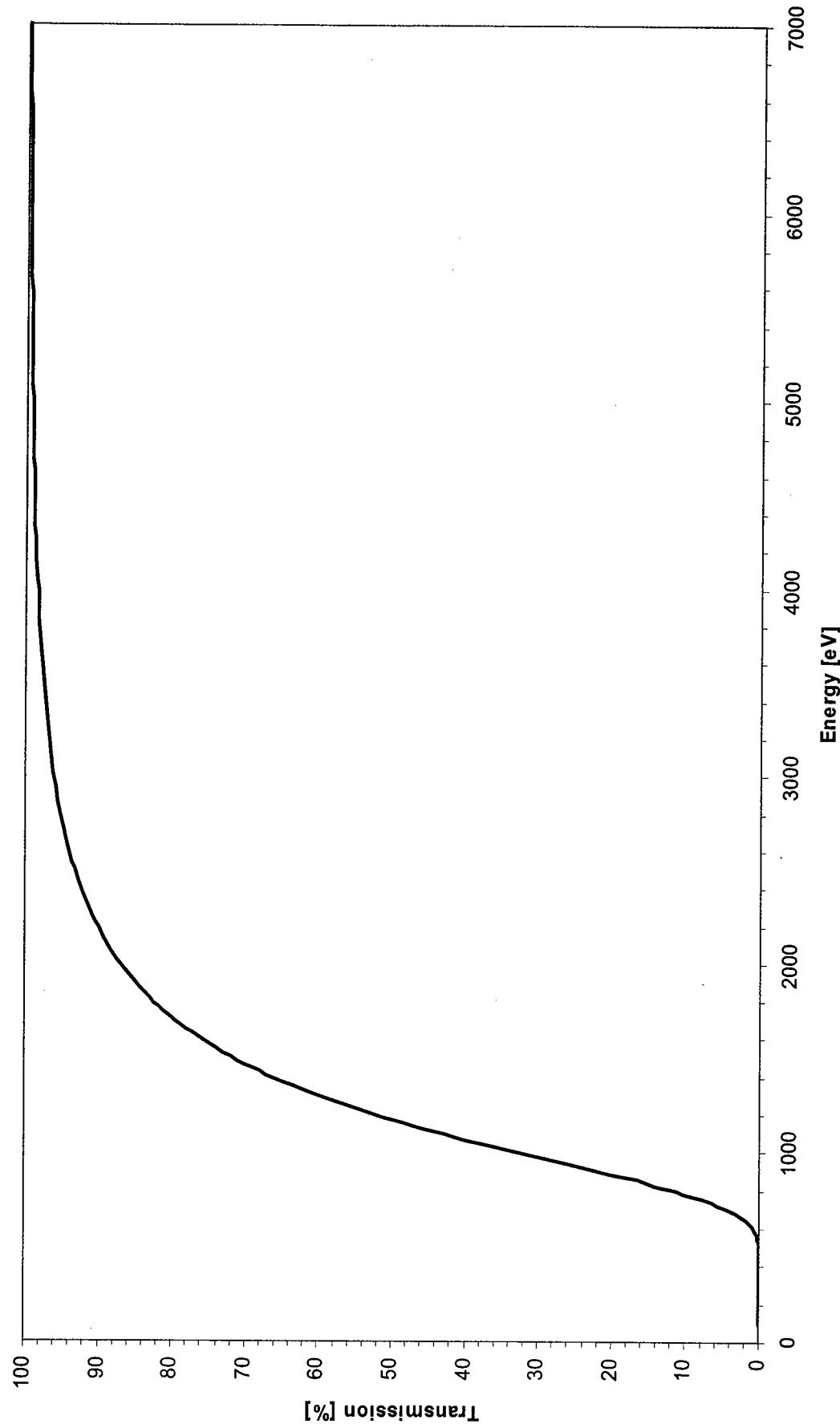
This picture shows the typical fall time (96.61 μ s in this case) of a pre-amplified signal (BNC / Preamp. OUT). Again a Fe⁵⁵ x-ray source was used to irradiate the detector. Please note that the amplitude and the total fall time of the signal depend on the x-ray energy and that the original output is inverted with respect to this picture.

Rise time of the pre-amplified signal



This picture shows the typical rise time (78.90 ns in this case) of a pre-amplified signal (BNC / Preamp. OUT). Again a Fe⁵⁵ x-ray source was used to irradiate the detector. Please note that the amplitude and the total rise time of the signal depend on the x-ray energy and that the original output is inverted with respect to this picture.

Transmission of a duraberyllium window



Transmission of a AP3.3 window

